

Notice of References Cited	Application/Control No. 10/541,092	Applicant(s)/Patent Under Reexamination TOYOZAWA ET AL.	
	Examiner Emmanuel Hailemariam	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0035862	11-2001	Nakamura et al.	345/204
*	B	US-2002/0041281	04-2002	Yanagi et al.	345/212
*	C	US-2002/0089477	07-2002	Kanbe et al.	345/87
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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